100V P-CHANNEL ENHANCEMENT MODE MOSFET

SUMMARY

 $V_{(BR)DSS}$ = - 100V : $R_{DS}(_{on})$ = 1 Ω ; I_{D} = - 0.7A

DESCRIPTION

This new generation of Trench MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.



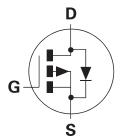
SOT23

FEATURES

- Low on-resistance
- Fast switching speed
- Low threshold
- · Low gate drive
- SOT23 package

APPLICATIONS

- DC-DC Converters
- Power Management functions
- · Disconnect switches
- Motor control

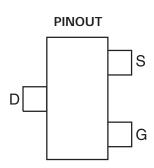


ORDERING INFORMATION

DEVICE	REEL SIZE	TAPE WIDTH	QUANTITY PER REEL
ZXMP10A13FTA	7″	8mm	3000 units
ZXMP10A13FTC	13"	8mm	10000units

DEVICE MARKING

• 7P1





ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DSS}	-100	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current @ V _{GS} =10V; T _A =25°C ^(b)	I _D	-0.7	А
@V _{GS} =10V; T _A =70°C ^(b)		-0.5	А
@ V _{GS} =10V; T _A =25°C ^(a)		-0.6	А
Pulsed Drain Current ^(c)	I _{DM}	-3.1	А
Continuous Source Current (Body Diode) (b)	I _S	-1.1	А
Pulsed Source Current (Body Diode) (c)	I _{SM}	-3.1	А
Power Dissipation at T _A =25°C ^(a)	P _D	625	mW
Linear Derating Factor		5	mW/°C
Power Dissipation at T _A =25°C ^(b)	P _D	806	mW
Linear Derating Factor		6.4	mW/°C
Operating and Storage Temperature Range	T _j , T _{stg}	-55 to +150	°C

THERMAL RESISTANCE

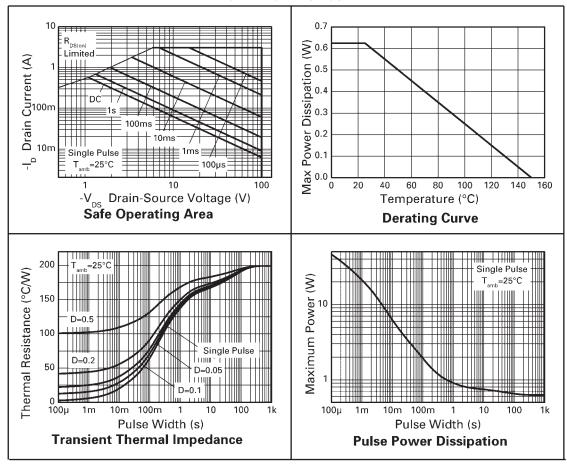
PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient ^(a)	$R_{\Theta JA}$	200	°C/W
Junction to Ambient ^(b)	$R_{\Theta JA}$	155	°C/W

NOTES

- (a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions. (b) For a device surface mounted on FR4 PCB measured at t ≤ 5 sec.
- (c) Repetitive rating 25mm x 25mm FR4 PCB, D = 0.02, pulse width 300μ s pulse width limited by maximum junction temperature.



CHARACTERISTICS





ELECTRICAL CHARACTERISTICS (at T_{amb} = 25°C unless otherwise stated)

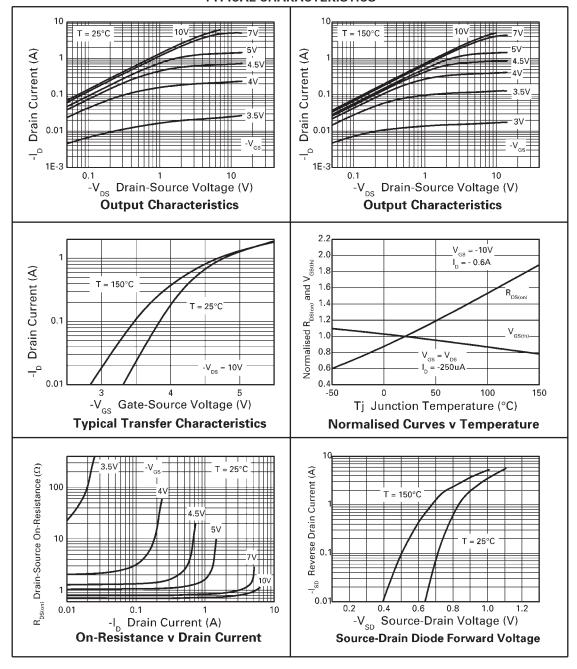
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS
STATIC						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	-100			V	I _D = -250μA, V _{GS} =0V
Zero Gate Voltage Drain Current	I _{DSS}			-1.0	μΑ	V _{DS} = -100V, V _{GS} =0V
Gate-Body Leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V
Gate-Source Threshold Voltage	V _{GS(th)}	-2.0		-4.0	V	I _D = -250μA, V _{DS} =V _{GS}
Static Drain-Source On-State	R _{DS(on)}			1	Ω	V _{GS} = -10V, I _D = -0.6A
Resistance ⁽¹⁾				1.45	Ω	V _{GS} = -6V, I _D = -0.5A
Forward Transconductance (1)(3)	g _{fs}		1.2		S	V _{DS} = -15V, I _D = -0.6A
DYNAMIC (3)		'	'			
Input Capacitance	C _{iss}		141		pF	
Output Capacitance	C _{oss}		13.1		pF	$V_{DS} = -50V, V_{GS} = 0V$
Reverse Transfer Capacitance	C _{rss}		10.8		pF	f=1MHz
SWITCHING (2) (3)	•	•	'			,
Turn-On Delay Time	t _{d(on)}		1.6		ns	
Rise Time	t _r		2.1		ns	V _{DD} = -50V, I _D = -1A
Turn-Off Delay Time	t _{d(off)}		5.9		ns	$R_G \cong 6.0\Omega$, $V_{GS} = -10V$
Fall Time	t _f		3.3		ns	1.6 = 0.012/ 1.63
Gate Charge	Qg		1.8		nC	V _{DS} = -50V, V _{GS} = -5V
						I _D = -0.6A
Total Gate Charge	Qg		3.5		nC	V _{DS} = -50V, V _{GS} = -10V
Gate-Source Charge	Q _{gs}		0.6		nC	$I_{DS} = -0.6A$
Gate-Drain Charge	Q _{gd}		1.6		nC	110- 0.071
SOURCE-DRAIN DIODE		•		•	•	
Diode Forward Voltage ⁽¹⁾	V _{SD}		-0.85	-0.95	V	T _j =25°C, I _S = -0.75A,
						V _{GS} =0V
Reverse Recovery Time ⁽³⁾	t _{rr}		29		ns	T _j =25°C, I _S = -0.9A,
Reverse Recovery Charge ⁽³⁾	Q _{rr}		31		nC	di/dt=100A/μs

NOTES

- (1) Measured under pulsed conditions. Pulse width \leq 300ms; duty cycle \leq 2%.
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.

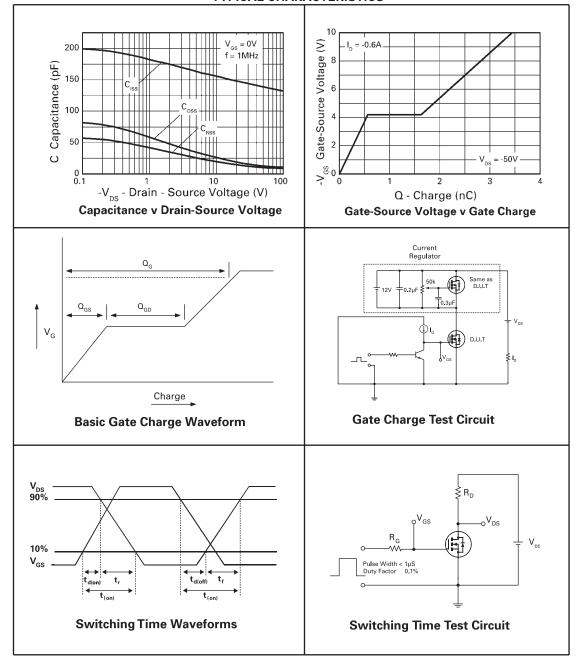


TYPICAL CHARACTERISTICS





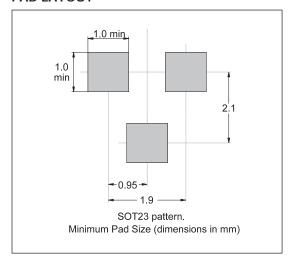
TYPICAL CHARACTERISTICS





PACKAGE OUTLINE

PAD LAYOUT



Controlling dimensions are in millimetres. Approximate conversions are given in inches

PACKAGE DIMENSIONS

	MILLIN	IETRES	INC	HES	MILLIMETRES		IETRES	INCHES	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
Α	2.67	3.05	0.105	0.120	Н	0.33	0.51	0.013	0.020
В	1.20	1.40	0.047	0.055	K	0.01	0.10	0.0004	0.004
С	_	1.10	_	0.043	L	2.10	2.50	0.083	0.0985
D	0.37	0.53	0.015	0.021	М	0.45	0.64	0.018	0.025
F	0.085	0.15	0.0034	0.0059	N	0.95 NOM		0.0375 NOM	
G	1.90	NOM	0.075	NOM	θ	10° TYP		10° TYP	

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